

	L #	Hits	Search Text	DBs	Time Stamp
5	L5	0	"330"/\$.ccls. and (rf near2 transistor\$) and ((output near3 match\$3) with (external near bias))	US- PGPUB; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TD B	2006/03/31 16:38
6	L6	0	"330"/\$.ccls. and (rf near2 transistor\$) and ((output near3 match\$3) with (external near3 bias))	US- PGPUB; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TD B	2006/03/31 16:39
7	L7	0	(rf near2 transistor\$) and ((output near3 match\$3) with (external near3 bias))	US- PGPUB; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TD B	2006/03/31 16:39

	L #	Hits	Search Text	DBs	Time Stamp
8	L8	0	(rf near2 transistor\$1) and ((output near3 match\$3) with (external near3 bias))	US- PGPUB; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TD B	2006/03/31 16:39
9	L9	6	((output near3 match\$3) with (external near3 bias))	US- PGPUB; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TD B	2006/03/31 16:48
10	L10	0	((output near3 match\$3) with (external near3 bias)) and (transistor with rf)	US- PGPUB; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TD B	2006/03/31 16:40

	L #	Hits	Search Text	DBs	Time Stamp
11	L11	6	((output near3 match\$3) with (external near3 bias))	US- PGPUB; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TD B	2006/03/31 16:40
12	L12	3	"330"/.ccls. and rf and (high near frequency near amplifier) and (DC near3 bias) and mmic	US- PGPUB; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TD B	2006/03/31 16:53
13	L13	21	"330"/.ccls. and (rf near3 transistor) and (DC near3 bias) and mmic	US- PGPUB; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TD B	2006/03/31 17:05

	L #	Hits	Search Text	DBs	Time Stamp
14	L14	22	"330"/.ccls. and (rf near3 transistor) and ((DC near4 bias) with input\$1) and (output near match\$3)	US- PGPUB; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TD B	2006/03/31 17:18
15	L15	0	"330"/.ccls. and (rf near3 transistor) and ((DC near4 bias) near3 external) and (output near match\$3)	US- PGPUB; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TD B	2006/03/31 17:19
16	L16	6	"330"/.ccls. and (rf near3 transistor) and (bias near3 external) and (output near match\$3)	US- PGPUB; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TD B	2006/03/31 17:20